Electronic supplementary information (ESI)

Giant change of MoS_2 optical properties along amorphous-crystalline transition: broadband spectroscopic study including NIR therapeutic window

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Contents

S1 Absorbance measurements of MoS_2 films on transparent substrates	S2
S2 Spectral deconvolution of MoS ₂ electric permittivity	S 3
S3 Wavelength dependence of MoS ₂ refractive index and extinction coefficient	S 4

Number of Supporting Information Pages: 4

Number of Supporting Information Figures: 3

Number of Supporting Information Tables: 0

S1 Absorbance measurements of MoS₂ films on transpa-

rent substrates

Optical transmittance spectra of as-deposited and annealed MoS_2 films were recorded in the wavelength range from 200 to 800 nm with the step of 2 nm using a JASCO V-570 UV/VIS/NIR spectrophotometer. The transparent substrates of fused silica were used for the transmittance measurements. Fig. S1 shows corresponding results presented in the form of absorbance. Experimental spectra of ellipsometry parameters, nearly-normal reflectance, and transmittance were treated simultaneously by multiple sample method. The right side of Fig. S1 indicates a change of the film color along the amorphous to 2H MoS_2 crystalline transition.



Figure S1 Absorbance spectra of MoS₂ thin films deposited on transparent fused quartz substrates. The excitonic features A, B, C, and D are also indicated.

S2 Spectral deconvolution of MoS₂ electric permittivity

 MoS_2 electric permittivity was parameterized as a sum of Lorentz oscillators. The resulting spectra of as-deposited and annealed films are plotted in Fig. S2 together with the individual contributions.



Figure S2 Spectral deconvolution of MoS_2 electric permittivity along the amorphous to 2H MoS_2 crystalline transition. Presented are the imaginary parts and their particular contributions.

S3 Wavelength dependence of MoS_2 refractive index and

extinction coefficient

Optical constants of MoS_2 are often reported in the literature in the form of the wavelength dependence of complex refractive index. For this reason, we provide in Fig S3 spectra of refractive index and extinction coefficients recalculated from the electric permittivity.



Figure S3 Spectral dependence of refractive index and extinction coefficient of MoS_2 of as-deposited and annealed films.